Power MOSFET 40 V, 8.9 A, 25 m Ω , Dual N–Channel SO–8

Features

- Low R_{DS(on)}
- Low Capacitance
- Optimized Gate Charge
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

| 3S (T _J = 2 | 5°C unless oth | nerwise state | d) | | | | | |
|---|---|---|--|---|-----|-----|----|----|
| Parameter | | Symbol | Value | Unit | | | | |
| Drain-to-Source Voltage | | V _{DSS} | 40 | V | | | | |
| age | | V _{GS} | ±20 | V | | | | |
| | $T_A = 25^{\circ}C$ | Ι _D | 7.4 | А | | | | |
| Steady | $T_A = 70^{\circ}C$ | | 5.9 | | | | | |
| State | $T_A = 25^{\circ}C$ | PD | 2.1 | W | | | | |
| | T _A = 70°C | 1 | 1.3 | | | | | |
| t<10 o | $T_A = 25^{\circ}C$ | ۱ _D | 8.9 | А | | | | |
| | $T_A = 70^{\circ}C$ | | 7.1 | | | | | |
| 1 210 5 | $T_A = 25^{\circ}C$ | PD | 3.0 | W | | | | |
| | $T_A = 70^{\circ}C$ | | 1.9 | | | | | |
| t _p = 10 μs | | I _{DM} | 35 | A | | | | |
| Operating Junction and Storage Temperature | | T _J , T _{STG} | –55 to +150 | °C | | | | |
| Source Current (Body Diode) | | ۱ _S | 7.0 | А | | | | |
| Single Pulse Drain-to-Source Avalanche Energy (L = 0.1 mH) | | | | 0 | | EAS | 20 | mJ |
| | | IAS | 21 | А | | | | |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | | ΤL | 260 | °C | | |
| | meter age age Steady State t ≤10 s t ≤10 s t_p = nd Storage / Diode) p=Source A | meter age $T_A = 25^{\circ}C$ $T_A = 70^{\circ}C$ $T_A = 70^{\circ}C$ $T_A = 70^{\circ}C$ $T_A = 70^{\circ}C$ $T_A = 25^{\circ}C$ $T_A = 25^{\circ}C$ $T_A = 25^{\circ}C$ $T_A = 70^{\circ}C$ | symbolageVDSSageVGSAgeVGSAgeTA = 25°CTA = 70°CIDTA = 70°CTA = 70°CTA = 70°CTA = 70°CTA = 70°CTA = 70°CTA = 25°CIDTA = 70°CTA = 70°CIDTA = 70°CIDTA = 70°CIDMto StorageISto Soldering PurposesTL | Age VDSS 40 Age VDSS 40 Age VDSS 40 Age VGS ±20 TA = 25°C ID 7.4 TA = 25°C PD 2.1 TA = 25°C PD 8.9 TA = 25°C ID 8.9 TA = 25°C ID 8.9 TA = 25°C ID 8.9 TA = 25°C PD 3.0 TA = 70°C 7.1 TA = 70°C PD 3.0 TA = 70°C IDM 3.5 odd Storage ID <th colsp<="" td=""></th> | | | | |

MAXIMI IM RATINGS (T. - 25°C unless otherwise stated)

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Ambient Steady State (Notes 1 & 3) | R_{\thetaJA} | 58 | |
| Junction–to–Ambient – t ≤10 s (Note 1) | R_{\thetaJA} | 40 | °C/W |
| Junction-to-Ambient Steady State (Note 2) | $R_{\theta JA}$ | 106 | |

1. Surface-mounted on FR4 board using 1 sq-in pad

(Cu area = 1.127 in sq [2 oz] including traces). 2. Surface-mounted on FR4 board using 0.155 in sq (100mm²) pad size.

3. Both channels receive equivalent power dissipation

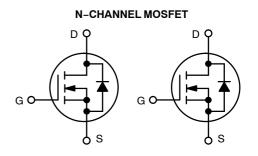
1 W applied on each channel: T_J = 2 W * 58°C/W + 25°C = 141°C



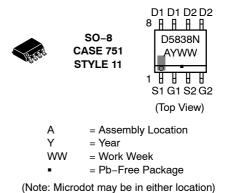
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| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX |
|----------------------|--|--------------------|
| 40 V | 25 mΩ @ 10 V | 8.9 A |
| 40 V | $30.8~\mathrm{m}\Omega$ @ $4.5~\mathrm{V}$ | 0.9 A |



MARKING DIAGRAM/ PIN ASSIGNMENT



ORDERING INFORMATION

| Device | Package | Shipping [†] |
|---------------|-------------------|-----------------------|
| NTMD5838NLR2G | SO-8 (Pb-Free) | 2500/Tape & Reel |

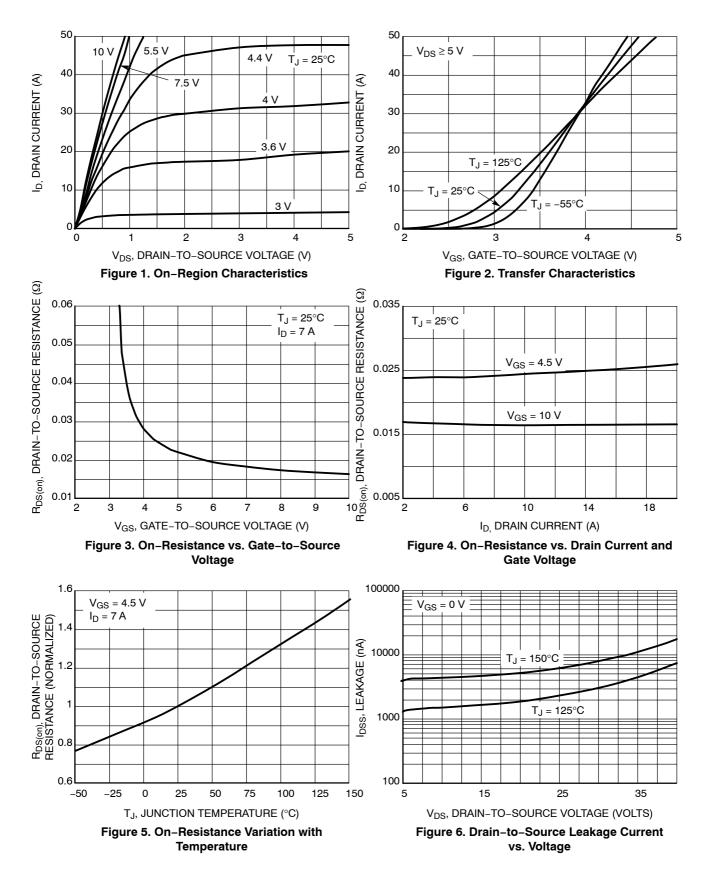
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

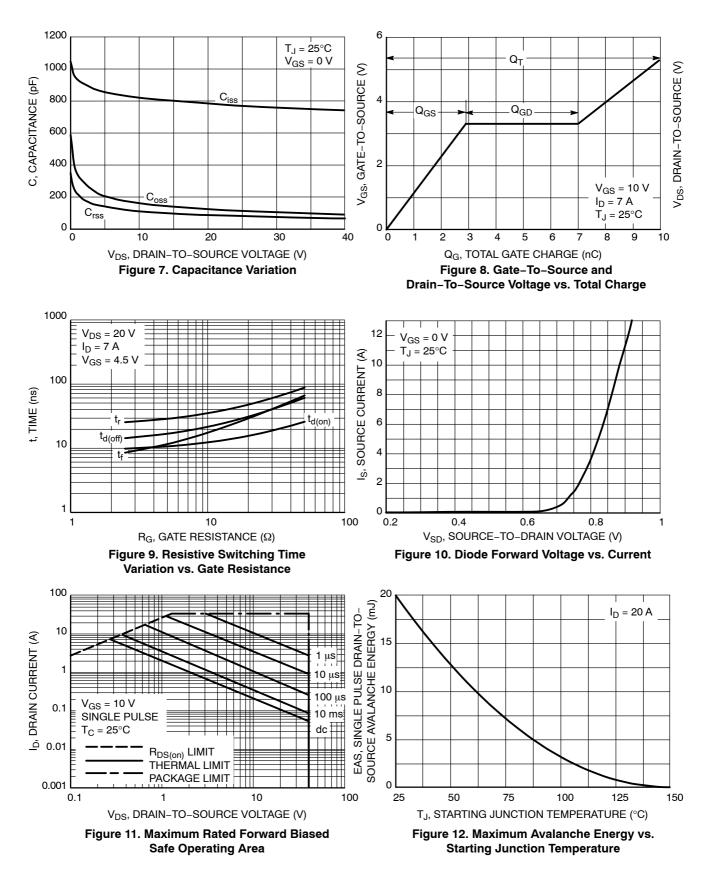
| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|--|--|------------------------|-----|------|------|---------|
| OFF CHARACTERISTICS | | | | | | | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V_{GS} = 0 V, I _D = 250 μ A | | 40 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} / T _J | | | | 32 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{GS} = 0 V,$ $V_{DS} = 40 V$ | T _J = 25 °C | | | 1.0 | μΑ |
| | | | T _J = 125°C | | | 100 | |
| Gate-to-Source Leakage Current | I _{GSS} | $V_{DS} = 0 V, V_{GS}$ | = ±20 V | | | ±100 | nA |
| ON CHARACTERISTICS (Note 4) | | | | - | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D =$ | = 250 μA | 1.0 | 1.8 | 3.0 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | 6.0 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V, I _D = 7 A | | | 20.5 | 25 | mΩ |
| | | V _{GS} = 4.5 V, I _D = 7 A | | | 25.0 | 30.8 | |
| Forward Transconductance | 9 _{FS} | V _{DS} = 15 V, I _E |) = 7 A | | 4.0 | | S |
| CHARGES, CAPACITANCES & GATE RESIS | TANCE | | | | | | |
| Input Capacitance | C _{ISS} | | | | 785 | | |
| Output Capacitance | C _{OSS} | V_{GS} = 0 V, f = 1 MHz, V_{DS} = 20 V | | | 123 | | pF |
| Reverse Transfer Capacitance | C _{RSS} | | | | 90 | | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 10 V, V _{DS} = 20 V; I _D = 7 A | | | 17 | | |
| | | | | | 8.6 | 11 | - |
| Threshold Gate Charge | Q _{G(TH)} | $V_{\rm GS}$ = 4.5 V, $V_{\rm DS}$ = 20 V; I _D = 7 A | | | 0.8 | | nC |
| Gate-to-Source Charge | Q _{GS} | | | | 2.8 | | |
| Gate-to-Drain Charge | Q _{GD} | | | | 4.0 | | |
| Plateau Voltage | V _{GP} | | | | 3.2 | | V |
| Gate Resistance | R _G | | | | 1.8 | | Ω |
| SWITCHING CHARACTERISTICS (Note 5) | | | | | | | |
| Turn-On Delay Time | t _{d(ON)} | | | | 11 | | |
| Rise Time | t _r | V _{GS} = 4.5 V, V _{DS} | s = 20 V. | | 23 | | 1 |
| Turn-Off Delay Time | t _{d(OFF)} | $I_{\rm D} = 7 {\rm A}, {\rm R}_{\rm G} = 2.5 {\Omega}$ | | | 17 | | ns - |
| Fall Time | t _f | | | | 4.0 | | |
| DRAIN-SOURCE DIODE CHARACTERISTIC | S | | | | | | |
| Forward Diode Voltage | V _{SD} | V _{GS} = 0 V, I _S = 7 A | T _J = 25°C | | 0.84 | 1.2 | v |
| | | | T _J = 125°C | | 0.7 | | |
| Reverse Recovery Time | t _{RR} | V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 7 A | | | 17 | | ns |
| Charge Time | t _a | | | | 11 | | |
| Discharge Time | t _b | | | | 6.0 | | |
| Reverse Recovery Charge | Q _{RR} | | | | 10 | | nC |

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES

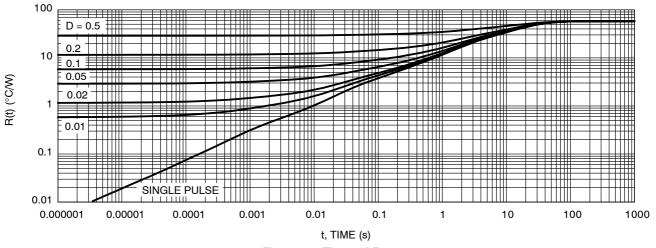
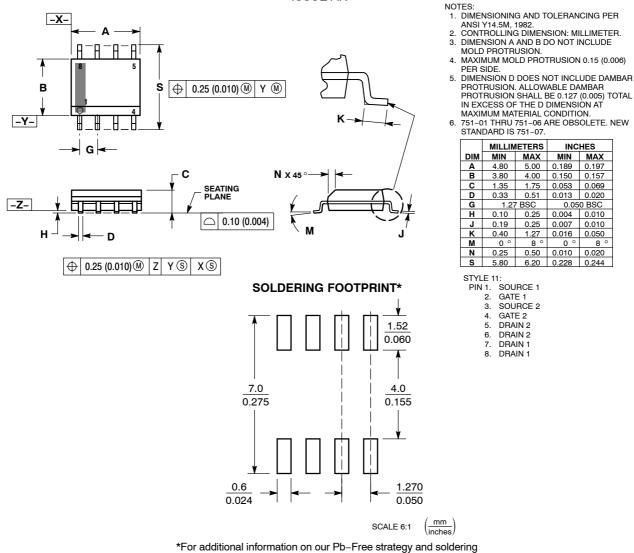


Figure 13. Thermal Response

PACKAGE DIMENSIONS

SOIC-8 NB CASE 751-07

ISSUE AK



details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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MILLIMETERS

4.80

3.80

1.35

0.33

0.19

0.40

0 °

0.25

MIN MAX

1.27 BSC

SOURCE 1

5.00 0.189

0.10 0.25 0.004 0.010

5.80 6.20 0.228 0.244

4.00 0.150 0.157

1.75 0.053 0.069

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0.50 0.010 0.020

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5 DRAIN 2 DRAIN 2 6.

7. DRAIN 1

8 DRAIN 1 INCHES

MIN MAX

0.050 BSC

0.197

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